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ATTY. DOCKET NO.

8932-146

APPLICATION NO.

09/660,287

APPLICANT

P. WEAVER et al.

FILING DATE

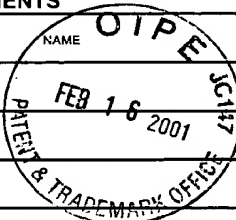
September 12, 2000

GROUP

3734 *2*

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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>SM</i>	AA	5,810,823	09/1998	Klaue et al.	606	69	
	AB	5,741,258	04/1998	Klaue et al.	606	70	
	AC	5,709,686	01/1998	Talos et al.	606	69	
	AD	5,601,553	02/1997	Trebing et al.	606	61	
	AE	5,429,641	07/1995	Gotfried	606	67	
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION *Abstract Only	
							YES	NO
<i>SM</i>	AO	WO 0053110	09/2000	PCT			X*	
	AP	WO 0053111	09/2000	PCT			X*	
	AQ	WO 97/09000	03/1997	PCT			X*	
	AR	DE 43 41 980 A1	06/1995	Germany			X*	
	AS	DE 43 43 117 A1	06/1995	Germany			X*	

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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373/2

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AA		5,772,662	6/1998	Chapman et al.	606	69	
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							YES	NO
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AM		2496429	5/1979	France			X*	
AN		2405706	5/1979	France			X*	
AO		2405705	5/1979	France			X*	
AP		2405062	5/1979	France			X*	
AQ		2233973	1/1975	France			X*	

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AA	6,096,040	8/2000	Esser	606	69	

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